

Notice of References Cited

Application/Control No.

10/769,684

Applicant(s)/Patent Under
Reexamination
BONILLA ET AL.

Examiner

LEON HARPER

Art Unit

2166

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0004956	01-2003	Johnson et al.	707/100
*	B	US-2002/0107872	08-2002	Hudis et al.	707/104.1
*	C	US-2002/0091809	07-2002	Menzies et al.	709/223
*	D	US-7,143,156	11-2006	Menzies et al.	709/223
*	E	US-7,054,853	05-2006	Johnson et al.	707/2
*	F	US-6,862,736	03-2005	Hudis et al.	719/316
*	G	US-6,317,748	11-2001	Menzies et al.	707/103X
*	H	US-2004/0260706	12-2004	Anonsen et al.	707/100
*	I	US-2004/0015506	01-2004	Anonsen et al.	707/100
*	J	US-2004/0015496	01-2004	Anonsen, Steven P.	707/4
*	K	US-2004/0015489	01-2004	Anonsen et al.	707/3
*	L	US-2004/0015470	01-2004	Smith et al.	707/1
*	M	US-7,412,436	08-2008	Trappen et al.	707/3

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,625,767	04-1997	Bartell et al.	345/440
*	B	US-7,478,409	01-2009	Scian et al.	719/328
*	C	US-6,141,714	10-2000	Arimilli et al.	710/107
*	D	US-2002/0156790	10-2002	Kagalwala et al.	707/100
*	E	US-2003/0172088	09-2003	Mandal et al.	707/200
*	F	US-7,143,156	11-2006	Menzies et al.	709/223
*	G	US-7,111,018	09-2006	Goodrich et al.	707/104.1
*	H	US-6,961,730	11-2005	Kagalwala et al.	707/102
*	I	US-2004/0172382	09-2004	Prang et al.	707/002
*	J	US-2004/0117350	06-2004	Cavage et al.	707/002
*	K	US-2002/0007360	01-2002	Hawkinson, Christopher D.	707/4
*	L	US-6,839,717	01-2005	Motoyama et al.	707/104.1
*	M	US-6,295,532	09-2001	Hawkinson, Christopher D.	707/4

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,208,994	03-2001	Abdelnur, Alejandro H.	707/103R
*	B	US-5,864,870	01-1999	Guck, Randal Lee	707/104.1
*	C	US-5,822,580	10-1998	Leung, Wyatt	707/103R
*	D	US-5,313,633	05-1994	Tomita et al.	707/1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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